

SCANNING INVENTION PROCESS**Abstract**

A method of identifying a full range of patentable aspects of an invention, the invention including broad and narrow aspects and includes the following steps. First, defining a first aspect of the invention, defining a first invention type of the invention, and defining a life cycle aspect of the invention. Second, modifying the first aspect while holding constant the first invention type and the life cycle aspect. Third, repeating the first and second steps until all the patentable aspect of the invention is defined.

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